Fe-doped and (Zn, Fe) co-doped CdS films: Could the Zn doping affect the concentration of Fe$^{2+}$ and the optical properties?

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Abstract

Cd$_{1-x}$Fe$_x$S and Cd$_{1-x-y}$Fe$_x$Zn$_y$S thin films were grown by low-pressure metal organic chemical vapor deposition (LP-MOCVD) on c-Al$_2$O$_3$ substrates. The films fabricated at 360°C under an hydrogen pressure of 76 Torr had hexagonal structure with only one (0 0 0 2) diffraction peak. The samples with low doping content have sharp absorption edges. It is found that the absorption edge and the emission peak positions of the Cd$_{1-x-y}$Fe$_x$Zn$_y$S film shift to high energy due to the Zn-doping. The band gap energy could be tuned in a wide range with the change of Zn content. The broadening of the Cd$_{1-x-y}$Fe$_x$Zn$_y$S emission peak could be attributed to the alloy fluctuations and the shallow defect in the samples.

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Keywords: Cd$_{1-x-y}$Fe$_x$Zn$_y$S; Absorption edges; Band gap energy

1. Introduction

During the last few years, there has been much interest in dilute magnetic semiconductors (DMS). DMSs are II–VI, IV–VI, or III–V compounds in which fraction of non-magnetic cations has been substituted by magnetic transition metal or rare-earth metal ions [1]. Most reports so far on these materials have focused on Mn, Fe, or Co mono-doped DMS [2–15], and few co-doped DMS materials have been reported [16]. It is well-known that co-doping can lead to remarkable change of the properties of DMS. Room temperature ferromagnetic can be observed for (Fe, Cu) co-doped ZnO film [17]. The Faraday rotations $\theta_F$ of CdMnCoTe and CdMnFeTe films were enhanced comparing with that of CdMnTe [18]. The Co-doped ZnO thin films showed a metallic conducting characteristic with low resistance, while the (Mn, Co) co-doped ZnO thin film had semiconductor conductivity with high resistance [19].

However, very limited information is available on the film quality, the optical and electronic properties of the co-doped CdS-based DMS materials.

CdS-based DMS is a good candidate for such applications as magneto-optical devices (magnetic field sensors, isolators and magneto-optical switches), field-emission displays, solar cells and gas sensors. In this letter, we prepared Cd$_{1-x}$Fe$_x$S and Cd$_{1-x-y}$Fe$_x$Zn$_y$S films with well preferred orientation on c-Al$_2$O$_3$ using MOCVD. The structure and composition of the films were characterized by the X-ray diffraction (XRD) and the energy dispersive spectroscopy (EDS). We have also investigated the optical and electrical properties of the films at room temperature.

2. Experiment

Cd$_{1-x}$Fe$_x$S and Cd$_{1-x-y}$Fe$_x$Zn$_y$S thin films were grown by a LP-MOCVD system with a horizontal rectangular quartz reactor. The ironpentacarbonyl (Fe(CO)$_5$), dimethylcadmium (DMCd), dimethylzinc (DMZn) and
hydrogen sulphide (H₂S) gas were used as source materials for Fe, Cd, Zn and S, respectively. The sapphire with (0 0 0 1) orientation (c-face) was used as the substrate. Before loaded into the reaction chamber, the substrates were cleaned by acetone and ethanol for 5 min in an ultrasonic bath and etched in an acid solution (3H₂SO₄ + 1H₃PO₄) for 5 min at 160 °C, followed by a de-ionized water rinse. Then the substrates were heated at 600 °C for 10 min in H₂ flow. During deposition, DMCd precursor is introduced into the reactor and the flow rate is kept at 5 ml/min. The Fe(NCO)₃ is cooled down to 0 °C with the flow rate ranging from 0 to 10 ml/min. DEZn is kept at 5 °C with the flow rate of 2 ml/min. All the depositions were operated at the pressure of 76 Torr and the growth temperature (Tg) was kept at 360 °C. The typical growth conditions are shown in Table 1.

The structural and composition of the samples were characterized by XRD and EDS, and their optical features were also investigated.

### Table 1

<table>
<thead>
<tr>
<th>Film</th>
<th>P (Torr)</th>
<th>Tg (°C)</th>
<th>Total H₂ (sccm)</th>
<th>Fe(NCO)₃ (20 °C) (sccm)</th>
<th>DMCd (−5 °C) (sccm)</th>
<th>DEZn (5 °C) (sccm)</th>
<th>H₂S (2 atm) (sccm)</th>
</tr>
</thead>
<tbody>
<tr>
<td>CdFeS</td>
<td>76</td>
<td>360</td>
<td>1900</td>
<td>1.4,7,10</td>
<td>8</td>
<td>0</td>
<td>13</td>
</tr>
<tr>
<td>CdZnFeS</td>
<td>76</td>
<td>360</td>
<td>1900</td>
<td>1.4,7,10</td>
<td>8</td>
<td>2</td>
<td>13</td>
</tr>
</tbody>
</table>

3. Results and discussions

The Cd₁₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋xEFeZnS films with low Fe content are yellow, very transparent with a very smooth surface. XRD data showed that the films are well crystallized. All of the other phases were detected, just as shown in Fig. 1. It can be seen that with increasing of the content of Fe and Zn, peaks of the (0 0 0 2) diffraction shift to larger angles. The reason for this is that both the radius of the Zn²⁺ and the Fe²⁺ are smaller than that of Cd²⁺. Meanwhile, the full width at half maximum (FWHM) of the XRD peaks becomes broader with the increase of the Fe and Zn dopants which is mostly due to the alloy fluctuation in samples. From Fig. 1, it can be concluded that highly preferred films could be prepared by LP-MOCVD even with high doping concentration. The compositions of Cd₁₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋xEFeZnS films determined by EDS. The Fe concentration in Cd₁₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋xEFeZnS films ranges from 0 to 0.35 (0 < x < 0.35), while that is 0 to 0.4 in Cd₁₋ₓ₋ₓ₋ₓ₋xEFeS films (0 < x < 0.4). It was indicated that Zn-doping could reduce the Fe-doping concentration slightly due to that Zn atom is easier to react with S than Fe atom. Therefore, the competition between Zn and Fe reacting with S caused the reduction of the Fe-doping concentration. The energy gap of Cd₁₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋xEFeZnS films can be obtained from the optical absorption spectra, just as shown in Fig. 2(a). The determination of the fundamental absorption gap and the fitting processing are performed as reported by David Dutton [20]. The sharp absorption edges of samples a, b and c confirms the good optical property of the Cd₁₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋ₓ₋xEFeZnS films. However, with further increase of the Fe composition, the slopes of the absorption edges become gentler. According to the optical absorption spectra of Fe-doped CdS in Fig. 2(b), it can be concluded that the slopes of the absorption edges become gentler with increasing Fe content, which possibly originates from the alloy fluctuation, defects absorption, Fe⁵⁺ intra-ion absorption and large exchange interaction of electrons in conduction and valence bands with the d electrons of Fe. Meanwhile, with the increase of Fe content, the absorption edges of CdFeS films shift to lower energy side due to the narrow band gap of FeS. Furthermore, comparing
Zn-doping could lead to remarkable increase of the band gap because the band gap of ZnS is much wider than that of CdS. Therefore, we could adjust the band gap energy in a wide range by changing the Zn composition. In order to study the effect of impurity on the optical properties, the photoluminescence (PL) spectra of the Cd$_{0.84}$Fe$_{0.16}$S, Cd$_{0.73}$Fe$_{0.27}$S, and Cd$_{0.60}$Fe$_{0.35}$S films were investigated as shown in Fig. 3. The PL peak position of Cd$_{0.84}$Fe$_{0.16}$S shifts to the lower energies side compared with that of CdS. The reason for this trend is that the band gap of FeS is narrower than that of CdS. When doped with Zn atoms, the PL peak position of Cd$_{0.84}$Fe$_{0.09}$Zn$_{0.11}$S shifts to the higher energies due to the band gap of ZnS is much wider than that of CdS and the content of Zn is larger than Fe. This result is good agreement with the optical absorption spectra shown in Fig. 2. The FWHM of the peak becomes broader with the increase of dopant content, which can be explained by the alloy fluctuations and the defects in the films. The PL peaks are attributed to the band-edge emission.

The electrical properties of the films are also measured, as summarized in Table 2. All the films showed a resistivity of 10$^4$–10$^3$ $\Omega$cm and did not have big change with changing the dopant concentration when a magnetic field of 15 000 Oe was applied. This result is much different from that of (Mn, Co) co-doped ZnO thin films reported by Yan et al. [19] and Gu et al. [21]. However, we find that the carrier density changes three orders of magnitude for the samples with different Fe and Zn doping concentration. Since the ions of Zn and Fe substituting for Cd in CdFeZnS films are isoelectronic centers and could not act as donor or acceptor, the change in carrier density from 10$^{12}$ to 10$^{15}$ cm$^{-3}$ might relate to the intrinsic defects or unintentionally incorporated impurities in the CdFeZnS films. In addition, Cd$_{0.60}$Fe$_{0.35}$Zn$_{0.05}$S film which is with the...
highest Fe concentration has the lowest Hall mobility. This indicates that the quality of the films was deteriorated with increasing Fe dopant concentration to a large amount.

4. Conclusions

High-quality Cd$_{1-x}$Fe$_x$S and Cd$_{1-x-y}$Fe$_x$Zn$_y$S thin films were grown on c-Al$_2$O$_3$ substrates by LP-MOCVD at 360°C and with the pressure of 76 Torr. The films have only (0 0 0 2) diffraction peaks in XRD pattern. Due to the doping of Zn, we could not only adjust the band gap energy in wide range, but also could control the doping content of Fe. Cd$_{1-x-y}$Fe$_x$Zn$_y$S thin films had good crystal quality with the Fe content below 0.3. According to this result, CdFeZnS films could be a promising material for applications of magneto-optical devices and solar cells.

Acknowledgments

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References


Table 2

Resistivity, Hall coefficient, carrier density and Hall mobility of the films

<table>
<thead>
<tr>
<th>Film</th>
<th>Resistivity (Ωcm)</th>
<th>Hall coefficient (cm$^3$/C)</th>
<th>Carrier density (cm$^{-3}$)</th>
<th>Hall mobility (cm$^2$/Vs)</th>
<th>Type</th>
</tr>
</thead>
<tbody>
<tr>
<td>Cd$<em>{0.88}$Fe$</em>{0.12}$S</td>
<td>$6.7519 \times 10^4$</td>
<td>$3.8525 \times 10^4$</td>
<td>$1.6203 \times 10^{14}$</td>
<td>$6.2028$</td>
<td>p</td>
</tr>
<tr>
<td>Cd$<em>{0.84}$Fe$</em>{0.16}$S</td>
<td>$1.3226 \times 10^5$</td>
<td>$9.6386 \times 10^4$</td>
<td>$6.4762 \times 10^{12}$</td>
<td>$7.6446$</td>
<td>p</td>
</tr>
<tr>
<td>Cd$<em>{0.60}$Fe$</em>{0.38}$Zn$_{0.02}$S</td>
<td>$4.5422 \times 10^4$</td>
<td>$3.0721 \times 10^4$</td>
<td>$1.4019 \times 10^{15}$</td>
<td>$0.0918$</td>
<td>p</td>
</tr>
<tr>
<td>Cd$<em>{0.88}$Fe$</em>{0.08}$Zn$_{0.04}$S</td>
<td>$5.8388 \times 10^4$</td>
<td>$5.6467 \times 10^4$</td>
<td>$1.1055 \times 10^{14}$</td>
<td>$6.2324$</td>
<td>P</td>
</tr>
<tr>
<td>Cd$<em>{0.85}$Fe$</em>{0.05}$Zn$_{0.10}$S</td>
<td>$2.4287 \times 10^4$</td>
<td>$-1.4142 \times 10^5$</td>
<td>$4.4141 \times 10^{13}$</td>
<td>$6.2504$</td>
<td>n</td>
</tr>
<tr>
<td>Cd$<em>{0.84}$Fe$</em>{0.11}$Zn$_{0.06}$S</td>
<td>$2.9009 \times 10^4$</td>
<td>$-1.0172 \times 10^5$</td>
<td>$6.1369 \times 10^{13}$</td>
<td>$3.5823$</td>
<td>n</td>
</tr>
</tbody>
</table>